

Description

The NTMFS4C03N-HXY uses advanced trench technology

to provide excellent RDS(ON), low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =150A

 $R_{DS(ON)} < 2.4 m\Omega V_{GS} = 10V$

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

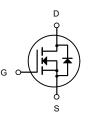
Product ID	Pack	Marking	Qty(PCS)
NTMFS4C03N-HXY	DFN5X6-8L	150N03 XXX YYYY	5000

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Parameter Rating	
Vds	Drain-Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
l₀@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	150	А
l₀@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	80	А
Ірм	Pulsed Drain Current ²	160	А
EAS	Single Pulse Avalanche Energy ³	180	mJ
las	Avalanche Current	60	А
P₀@Tc=25°C	Total Power Dissipation ⁴	187	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient ¹	62	°C/W
Rejc	Thermal Resistance Junction-Case ¹	1.1	°C/W







N-Channel MOSFET

N-Channel Enhancement Mode MOSFET



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
$\triangle BV_{\text{DSS}} / \triangle T_{\text{J}}$	BV _{DSS} Temperature Coefficient	Reference to 25° C , I _D =1mA		0.014		V/°C	
P	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =30A		2	2.4	mΩ	
RDS(ON)	Static Drain-Source On-Resistance-	V _{GS} =4.5V , I _D =15A		2.5	3.2		
$V_{\text{GS(th)}}$	Gate Threshold Voltage		1.2		2.5	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250 uA$		-4		mV/°C	
I	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	– uA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		50		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω	
Qg	Total Gate Charge (4.5V)			56.9			
Qgs	Gate-Source Charge	V_{DS} =15V , V_{GS} =10V , I_{D} =15A		13.8		nC	
Q_{gd}	Gate-Drain Charge			23.5		1	
T _{d(on)}	Turn-On Delay Time			20.1			
Tr	Rise Time	V_{DD} =15V , V_{GS} =10V , R_{G} =3.3 Ω ,		6.3		20	
T _{d(off)}	Turn-Off Delay Time	I _D =1A		124.6		ns	
T _f	Fall Time			15.8		1	
Ciss	Input Capacitance			4345			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		340		pF	
Crss	Reverse Transfer Capacitance			225			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,6}	$V_G=V_D=0V$, Force Current			150	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , TJ=25°C			1.2	V

Note :

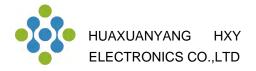
1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =60A

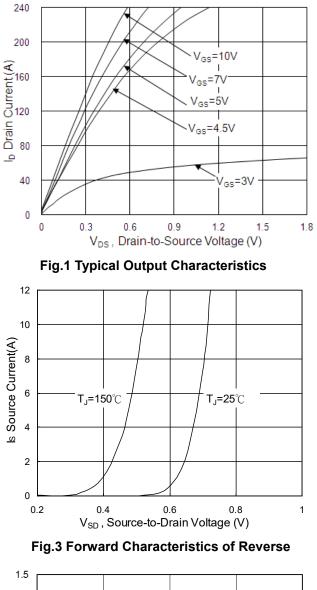
4.The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation. 6. Package limitation current is 85A.



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Typical Characteristics



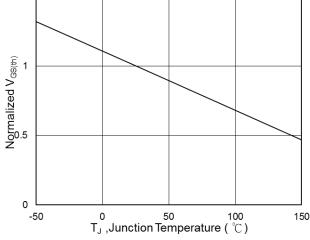


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

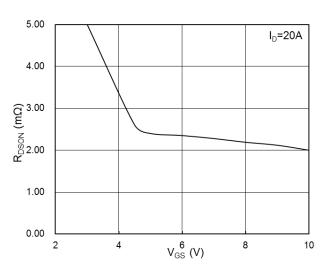


Fig.2 On-Resistance v.s Gate-Source

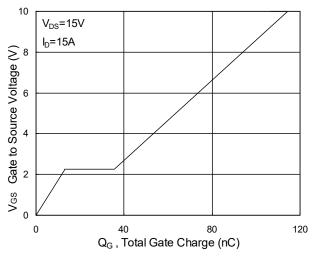


Fig.4 Gate-Charge Characteristics

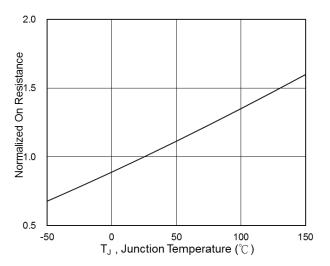


Fig.6 Normalized R_{DSON} v.s T_J



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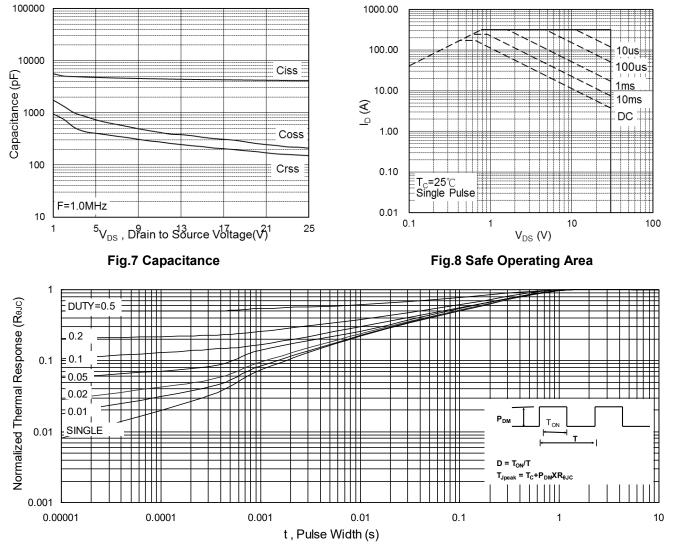


Fig.9 Normalized Maximum Transient Thermal Impedance

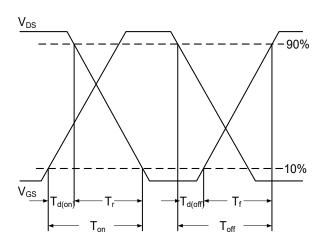


Fig.10 Switching Time Waveform

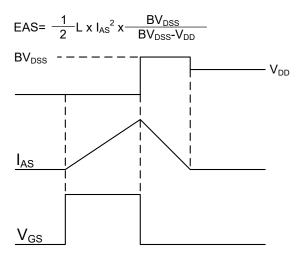
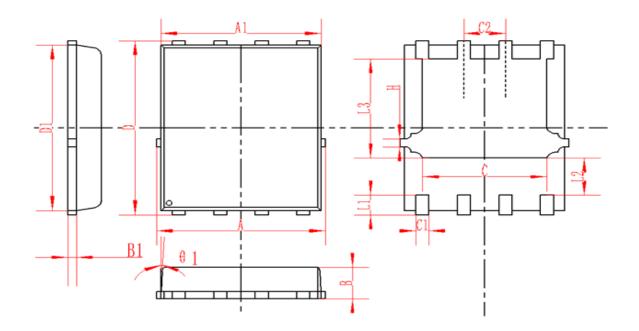


Fig.11 Unclamped Inductive Switching Waveform



DFN5X6-8L Package Information



SYMBOL		MM			INCH		
STIVIDOL	MIN	NOM	MAX	MIN	NOM	MAX	
А	4.95	5	5.05	0.195	0.197	0.199	
A1	4.82	4.9	4.98	0.190	0.193	0.196	
D	5.98	6	6.02	0.235	0.236	0.237	
D1	5.67	5.75	5.83	0.223	0.226	0.230	
В	0.9	0.95	1	0.035	0.037	0.039	
B1		0.254REF			0.010REF		
С	3.95	4	4.05	0.156	0.157	0.159	
C1	0.35	0.4	0.45	0.014	0.016	0.018	
C2		1.27TYP			0.5TYP		
θ1	8°	10°	12°	8°	10°	12°	
L1	0.63	0.64	0.65	0.025	0.025	0.026	
L2	1.2	1.3	1.4	0.047	0.051	0.055	
L3	3.415	3.42	3.425	0.134	0.135	0.135	
Н	0.24	0.25	0.26	0.009	0.010	0.010	



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